

Search Notes

Application/Control No.

10/509,461

Examiner

Henok G. Heyi

Applicant(s)/Patent under
Reexamination

VAN DEN OETELAAR ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	275.1	11/6/2007	HH
369	94	11/6/2007	HH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched and consulted primary Tan Dinh.	11/6/2007	HH